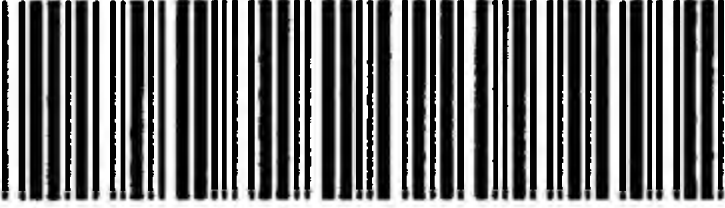


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/709,519	SAITOH, MANABU	
	Examiner	Art Unit	
	Y. J. Han	2838	

SEARCHED			
Class	Subclass	Date	Examiner
.323	222		
	225		
	247		
	276		
	282		
	284		
	285		
	299		
	301	2/06	gH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR